Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,309	PATELLA ET AL.	
Examiner	Art Unit	
Minh Nguyen	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
327	27	4/1/2005	MN		
above	updated	8/19/2005	MN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	search, see tout	8/19/2005	MN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB), see printout	4/1/2005	MN		
Limited search (327/2-3,7,12,23-27, 713/320-340,400,401,500-503; 324/76.54,76.55), see printout	4/1/2005	MN		
Updated, see printout	8/19/2005	MN		